

n-Channel Power MOSFET

OptiMOS™ BSB014N04LX3 G

Data Sheet

2.3, 2011-05-24 Final

Industrial & Multimarket

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1 Description

OptiMOS[™]40V products are class leading power MOSFETs for highest power density and energy efficient solutions. Ultra low gate- and output charges together with lowest on state resistance in small footprint packages make OptiMOS™ 40V the best choice forthe demanding requirements of voltage regulator solutions in Servers, Datacom and Telecom applications. Super fast switching Control FETs together with low EMI Sync FETs provide solutions that are easy to design in. OptiMOS[™] products are available in high performance packages to tackle your most challenging applications giving full flexibility in optimizing space- efficiency and cost. OptiMOS™ products are designed to meet and exceed the energy efficiency and power density requirements of the sharpened next generation voltage regulation standards in computing applications

Features

- Optimized for high switching frequency DC/DC converter
- 100% avalanche tested •
- Excellent gate charge x $R_{DS(on)}$ product (FOM) Qualified according to JEDEC¹⁾ for target applications •
- Pb-free plating; RoHS compliant ٠
- Very low on-resistance R_{DS(on)}
- Low profile (<0.7 mm)
- Low parasitic inductance
- Double.sided cooling
- Compatible with DirectFET® package MX footprint and outline
- 100% Rg Tested

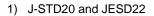
Applications

- On board power for server
- Power managment for high performance computing
- Synchronous rectification
- High power density point of load converters

Table 1 **Key Performance Parameters**

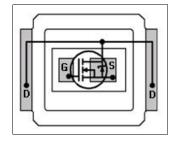
Parameter	Value	Unit	Related Links
V _{DS}	40	V	IFX OptiMOS webpage
R _{DS(on),max}	1.4	mΩ	IFX OptiMOS product brief
I _D	180	A	IFX OptiMOS spice models
Q _{OSS}	89	nC	IFX Design tools
Q _{g·typ}	148		

Туре	Package	Marking
BSB014N04LX3 G	MG-WDSON-2	0104













2 Maximum ratings

at $T_i = 25 \text{ °C}$, unless otherwise specified.

Table 2Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Тур.	Max.		
Continuous drain current	I _D	-	-	180	А	V _{GS} =10 V, <i>T</i> _C =25 °C
				128		V _{GS} =10 V, T _C =100 °C
				36		$V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =45 K/W ¹⁾
Pulsed drain current ²⁾	I _{D,pulse}	-	-	400		<i>T</i> _C =25 °C
Avalanche current, single pulse ³⁾	I _{AS}	-	-	50		
Avalanche energy, single pulse	E _{AS}	-	-	260	mJ	<i>I</i> _D =50 A, <i>R</i> _{GS} =25 Ω
Gate source voltage	V _{GS}	-20	-	20	V	
Power dissipation	P _{tot}	-	-	89	W	<i>T</i> _C =25 °C
				2.8		<i>T</i> _A =25 °C, <i>R</i> _{thJA} =45 K/W
Operating and storage temperature	$T_{\rm j}, T_{\rm stg}$	-40	-	150	°C	
IEC climatic category; DIN IEC 68-1		55	150	56	Ncm	

1) J-STD22 and JESD22

2) See figure 3 for more detailed information

3) See figure 13 for more detailed information

3 Thermal characteristics

Table 3Thermal characteristics

Parameter	Symbol		Value	s	Unit	Note / Test Condition
		Min.	Тур.	Max.		
Thermal resistance, junction - case	$R_{ m thJC}$	-	1.0	-	°K/W	bottom
				1.4		top
Device on PCB	R _{thJA}	-	-	45		6 cm ² cooling area ¹⁾

Device on 40 mm x 40 mm x 1.5 epoxy PCB FR4 with 6 cm2 (one layer, 70µm thick) copper area for drain connection. PCB is vertical in still air.

2



Electrical characteristics

4 Electrical characteristics

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified.

Table 4Static characteristics

Parameter	Symbol		Value	s	Unit	Note / Test Condition	
		Min.	Тур.	Max.			
Drain-source breakdown voltage	V _{(BR)DSS}	40	-	-	V	V _{GS} =0 V, <i>I</i> _D =1.0 mA	
Gate threshold voltage	V _{GS(th)}	1.2	-	2		$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 250 \ \mu \text{A}$	
Zero gate voltage drain current	I _{DSS}	-	0.1	10	μA	$V_{\rm DS}$ =40 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	
		-	10	100		$V_{\rm DS}$ =40 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =125 °C	
Gate-source leakage current	I _{GSS}	-	10	100	nA	V _{GS} =20 V, V _{DS} =0 V	
Drain-source on-state resistance	$R_{\rm DS(on)}$	-	1.6	2	mΩ	V _{GS} =4.5 V, <i>I</i> _D =25A	
		-	1.2	1.4		V _{GS} =10 V, <i>I</i> _D =30 A	
Gate resistance	R _G	0.2	0.5	1.0	Ω		
Transconductance	g _{fs}	65	130		S	$ V_{\rm DS} >2 I_{\rm D RDS(on)max},$ $I_{\rm D}=30$ A	

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note /	
		Min.	Тур.	Max.		Test Condition	
Input capacitance	C_{iss}	-	12700	16900	pF	$V_{\rm GS}$ =0 V, $V_{\rm DS}$ =20 V,	
Output capacitance	C _{oss}	-	2400	3200		<i>f</i> =1 MHz	
Reverse transfer capacitance	C _{rss}	-	140	-			
Turn-on delay time	t _{d(on)}	-	12	-	ns	$V_{\rm DD}$ =20V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G}$ = 1.6 Ω	
Rise time	<i>t</i> _r	-	8.4	-		<i>I</i> _D =30 A, <i>R</i> _G = 1.6 Ω	
Turn-off delay time	t _{d(off)}	-	60	-			
Fall time	t _f	-	10	-			



Electrical characteristics

Parameter	Symbol		Value	s	Unit	Note / Test Condition
		Min.	Тур.	Max.		
Gate to source charge	Q _{gs}	-	33	-	nC	V _{DD} =20 V,
Gate charge at threshold	Q _{g(th)}	-	19	-		<i>I</i> _D =30 A, <i>V</i> _{GS} =0 to 10 ∨
Gate to drain charge	Q _{gd}	-	15	-		
Switching charge	Q _{sw}	-	29	-		
Gate charge total	Qg	-	148	196		
Gate plateau voltage	V _{plateau}	-	2.8	-	V	
Gate charge total	Qg	-	71	95	nC	$V_{\rm DD}$ =20 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 4.5V
Gate charge total, sync. FET	Q _{g(sync)}		139			$V_{\rm DS}$ =0.1 V, $V_{\rm GS}$ =0 to 10 V
Output charge	Q _{oss}		89			$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =

Table 6 Gate charge characteristics¹⁾

1) See figure 16 for gate charge parameter definition

Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note /
		Min.	Тур.	Max.		Test Condition
Diode continuous forward current	I _s			81	А	<i>T</i> _C =25 °C
Diode pulse current	I _{S,pulse}			400		
Diode forward voltage	V _{SD}	-	0.77	1.1	V	$V_{GS}=0 V, I_{F}=30 A, T_{j}=25 °C$
Reverse recovery charge	Q _{rr}	-	-	50	nC	V _R =15 V, I _F =I _s , d <i>i</i> _F /d <i>t</i> =400 A/μs



5 Electrical characteristics diagrams

Table 8

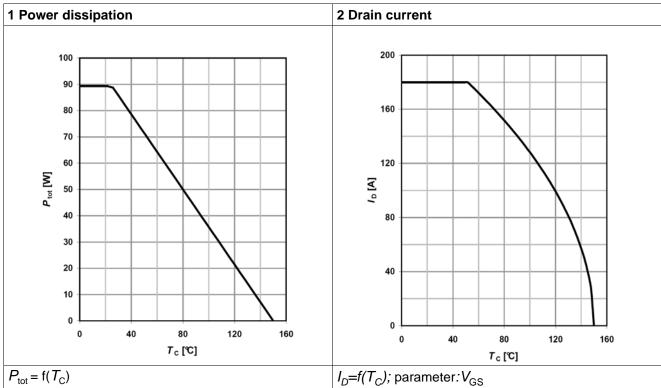


Table 9

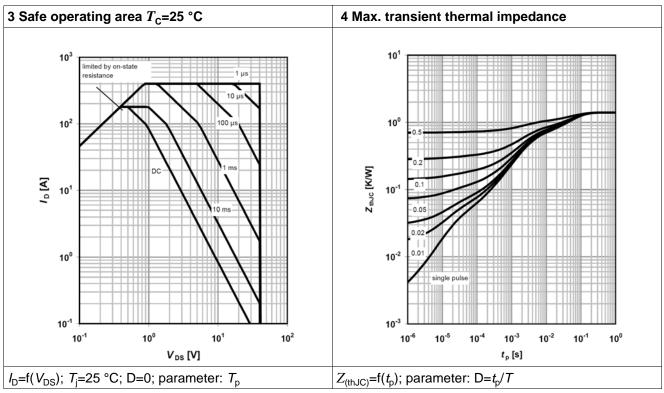
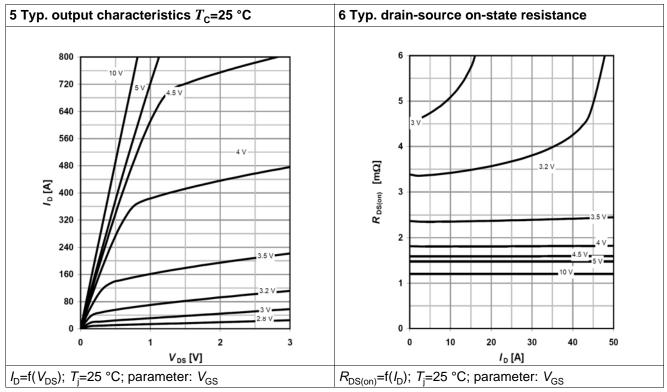
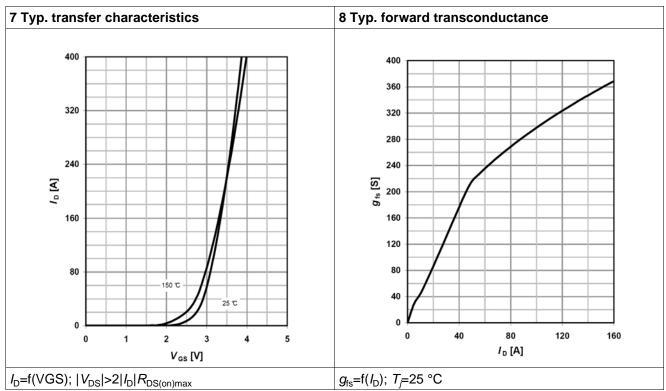




Table 10



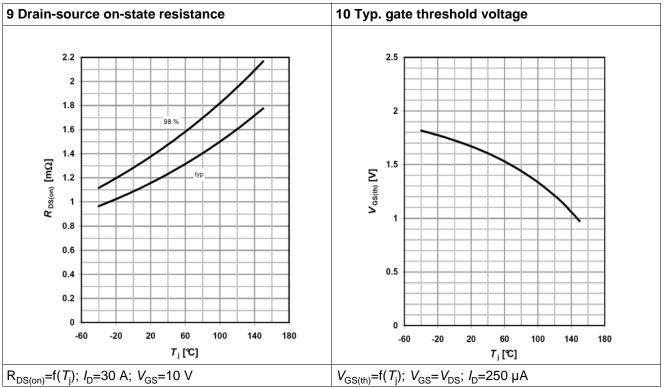




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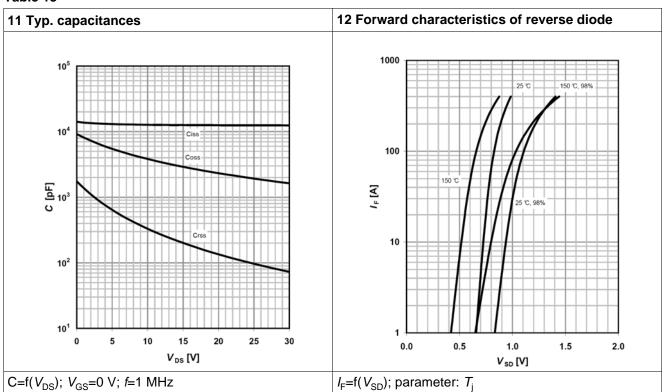




Table 14

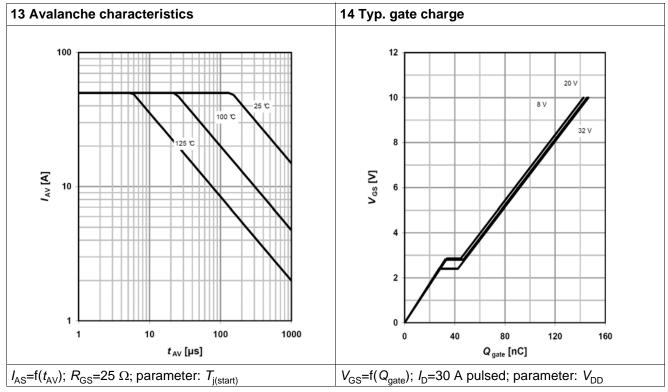
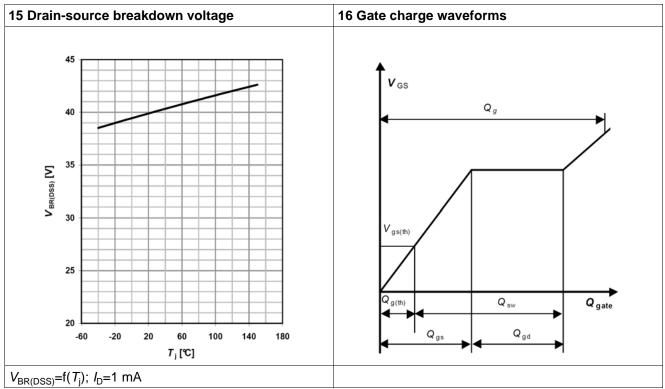


Table 15





Package outlines

6 Package outlines

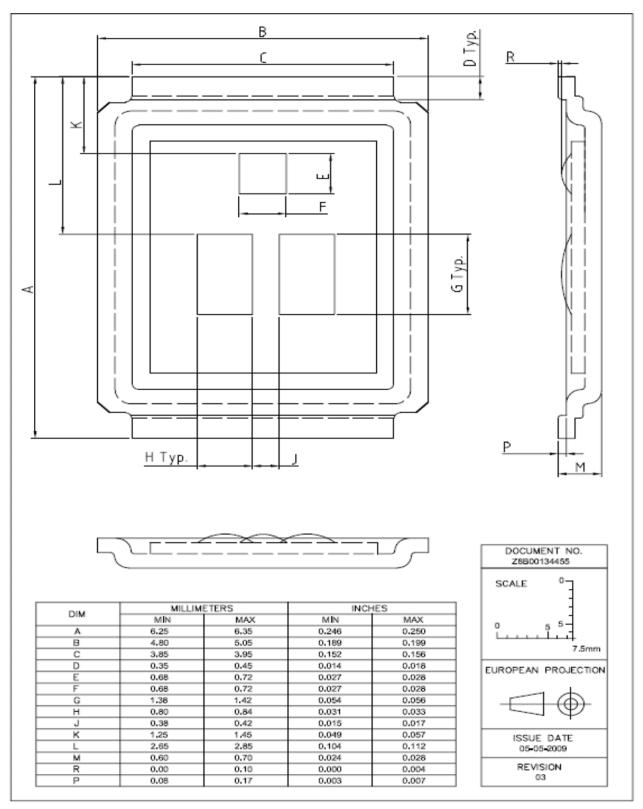


Figure 1 Outlines MG-WDSON-2, dimensions in mm/inches



Package outlines

7 Package outlines

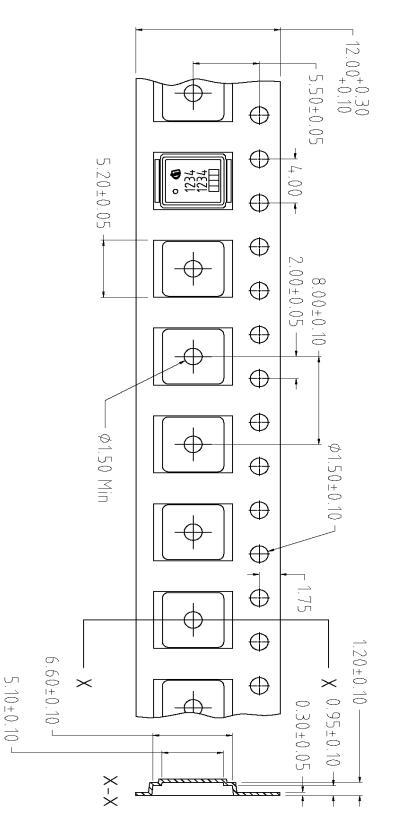


Figure 2 Outlines MG-WDSON-2, dimensions in mm/inches



Package outlines

8 Package outlines

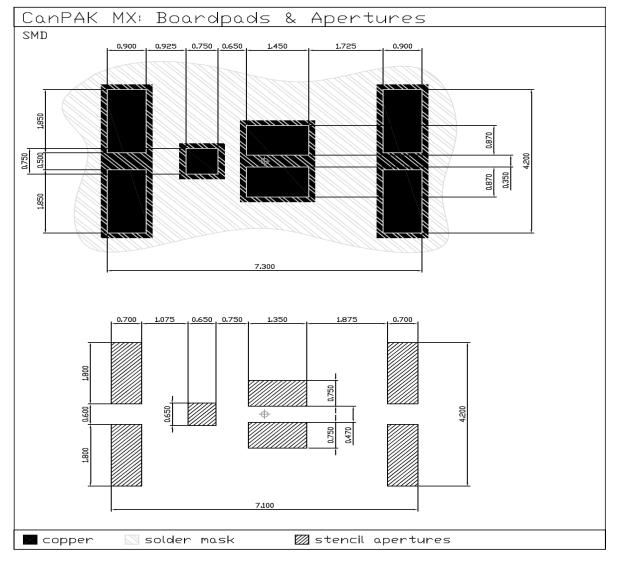
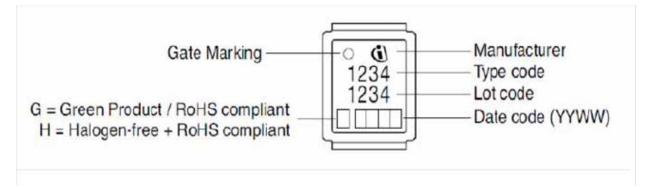


Figure 3 Outlines MG-WDSON-2, dimensions in mm/inches

9 Marking layout





Revision History

9 Revision History

Revision History: 2011-05-24, 2.3

Previous Revision:					
Revision	Subjects (major changes since last revision)				
0.1	Release of target data sheet				
2.2	DirectFET Disclaimer Expired				
2.3	Insert Marking Layout				

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